Search Notes



Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/709,096	MURAYAMA ET AL.	
Examiner	Art Unit	
Junghwa M. Im	2811	

SEARCHED				
Class	Subclass	Date	Examiner	
257	738,778	2/2/2005	JMI	
257	733,689	2/2/2005	JMI	
257	737,779	2/2/2005	JMI	
257	780	2/2/2005	JMI	
above	updated	11/10/2006	ЈМІ	
257.	723,678	11/10/2006	JMI	
257	700	11/10/2006	JMI	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
As	above	11/10/2006	JMI	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST (uspat, uspub, epo, jpo, der, ibm)	11/10/2006	JMI
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